



UT02P06

POWER MOSFET

-0.2A, -60V P-CHANNEL POWER MOSFET

DESCRIPTION

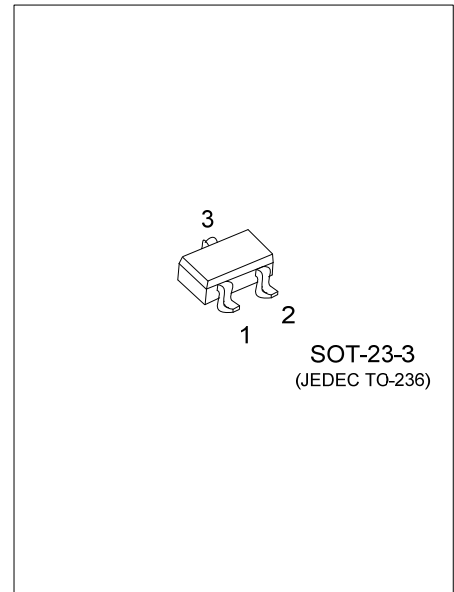
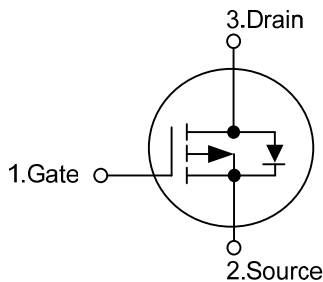
The UTC **UT02P06** is a P-channel MOS Field Effect Transistor. it uses UTC's advanced technology to provide the customers with high switching speed and a minimum on-state resistance.

The UTC **UT02P06** is suitable for high voltage switching applications.

FEATURES

- * $R_{DS(ON)} \leq 4.0 \Omega @ V_{GS} = -10V, I_D = -0.1A$
- $R_{DS(ON)} \leq 6.0 \Omega @ V_{GS} = -4.5V, I_D = -0.1A$
- * High switching speed
- * Low input capacitance

SYMBOL



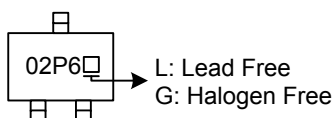
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UT02P06L-AE2-R	UT02P06G-AE2-R	SOT-23-3	G	S	D	Tape Reel

Note: Pin Assignment: G: Gate S: Source D: Drain

Ordering Number	Pin Assignment	Packing
UT02P06G-AE2-R	(1)Packing Type (2)Package Type (3)Green Package	(1) R: Tape Reel (2) AE2: SOT-23-3 (3) G: Halogen Free and Lead Free, L: Lead Free

MARKING



■ ABSOLUTE MAXIMUM RATING ($T_C=25^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage	V_{DSS}	-60	V	
Gate-Source Voltage	V_{GSS}	± 20	V	
Drain Current	DC	I_D	-0.2	A
	Pulsed (Note 2)	I_{DM}	-0.4	A
Power Dissipation ($T_A=25^\circ\text{C}$)	P_D	0.2	W	
Junction Temperature	T_J	+150	$^\circ\text{C}$	
Storage Temperature Range	T_{STG}	-55 ~ +150	$^\circ\text{C}$	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	625	$^\circ\text{C/W}$

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

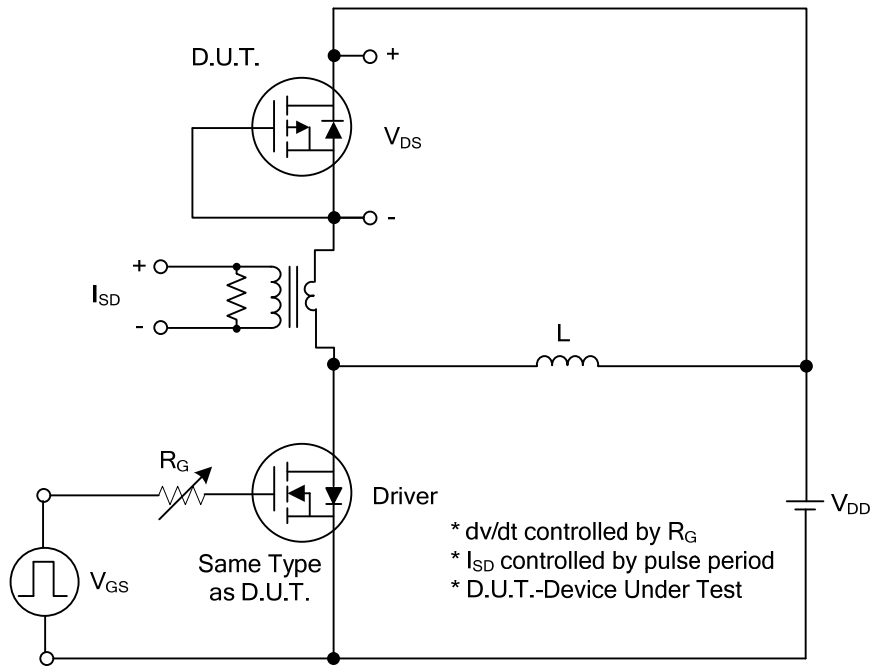
■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-60			V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=-60\text{V}, V_{GS}=0\text{V}$			-1	μA
Gate-Source Leakage Current	I_{GSS}	Forward $V_{GS}=+20\text{V}, V_{DS}=0\text{V}$			+10	μA
		Reverse $V_{GS}=-20\text{V}, V_{DS}=0\text{V}$			-10	μA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1.0		-3.0	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=-10\text{V}, I_D=-0.1\text{A}$			4.0	Ω
		$V_{GS}=-4.5\text{V}, I_D=-0.1\text{A}$			6.0	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{GS}=0\text{V}, V_{DS}=-10\text{V}, f=1.0\text{MHz}$		28		pF
Output Capacitance	C_{OSS}			7		pF
Reverse Transfer Capacitance	C_{RSS}			4		pF
SWITCHING PARAMETERS						
Total Gate Charge	Q_G	$V_{DS}=-48\text{V}, V_{GS}=-10\text{V}, I_D=-0.2\text{A}, I_D=-1\text{mA}$ (Note 1, 2)		7		nC
Gate to Source Charge	Q_{GS}			1		nC
Gate to Drain Charge	Q_{GD}			0.6		nC
Turn-ON Delay Time	$t_{D(ON)}$	$V_{DS}=-30\text{V}, V_{GS}=-10\text{V}, I_D=-0.2\text{A}, R_G=3\Omega$ (Note 1, 2)		2		ns
Rise Time	t_R			19		ns
Turn-OFF Delay Time	$t_{D(OFF)}$			7		ns
Fall-Time	t_F			30		ns
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Continuous Drain-Source Diode Forward Current	I_S				-0.2	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				-0.4	A
Diode Forward Voltage	V_{SD}	$I_F=-0.2\text{A}, V_{GS}=0\text{V}$			-1.4	V

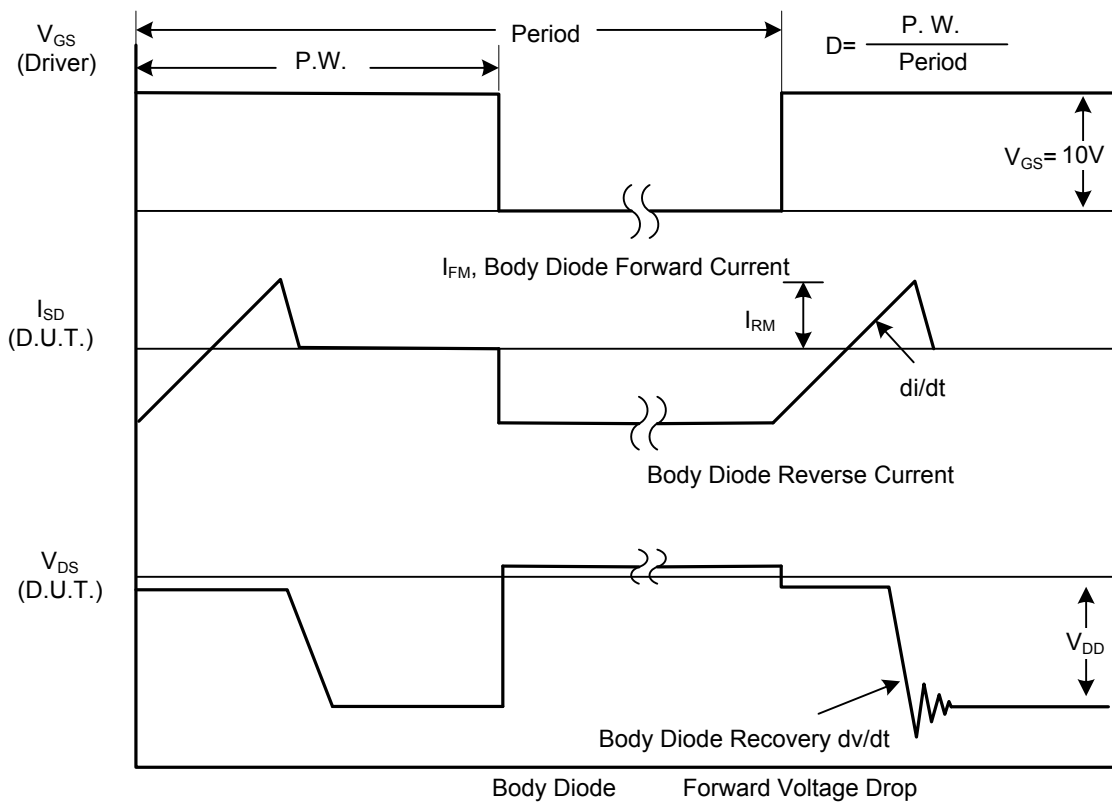
Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

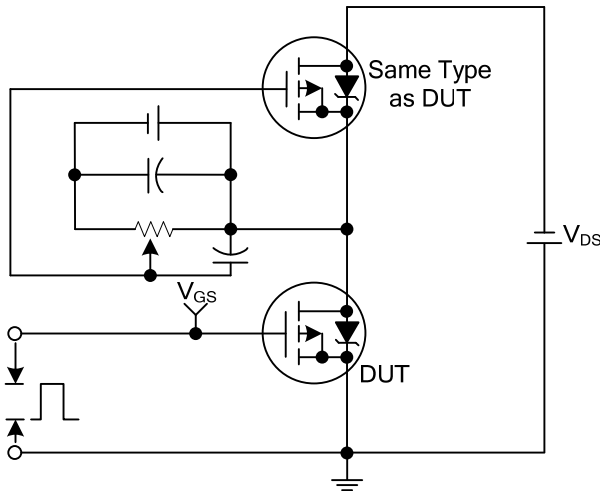


Peak Diode Recovery dv/dt Test Circuit

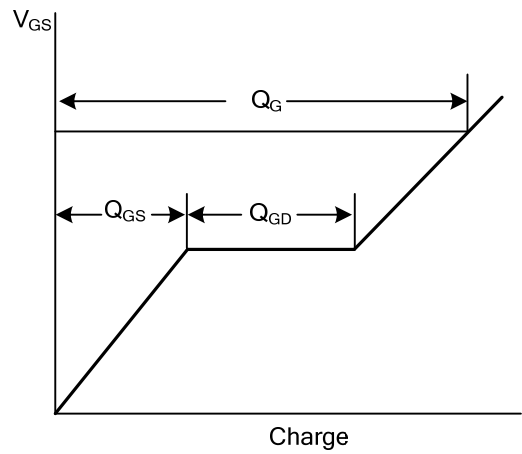


Peak Diode Recovery dv/dt Waveforms

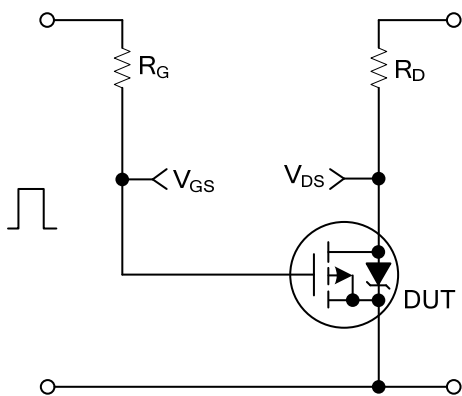
■ TEST CIRCUITS AND WAVEFORMS



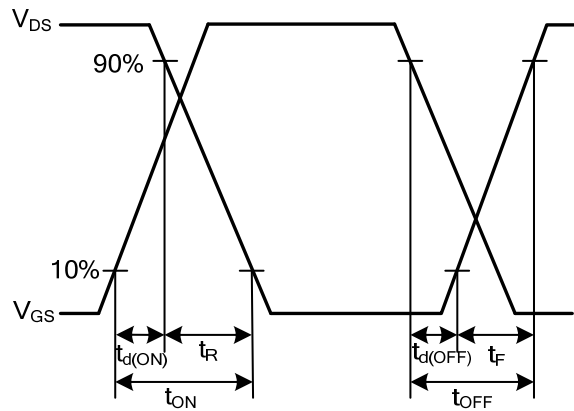
Gate Charge Test Circuit



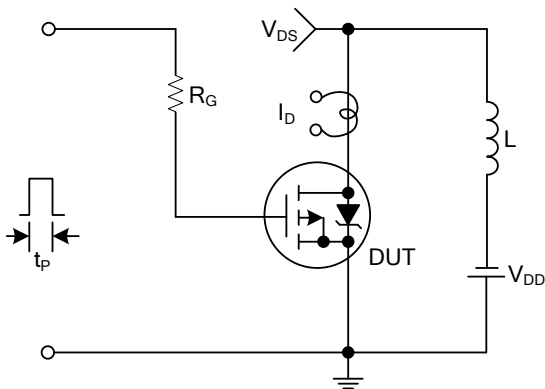
Gate Charge Waveforms



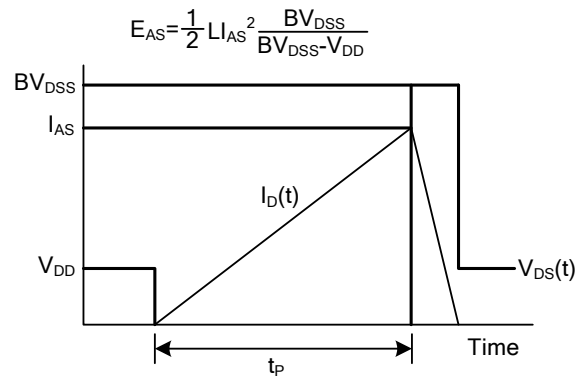
Resistive Switching Test Circuit



Resistive Switching Waveforms

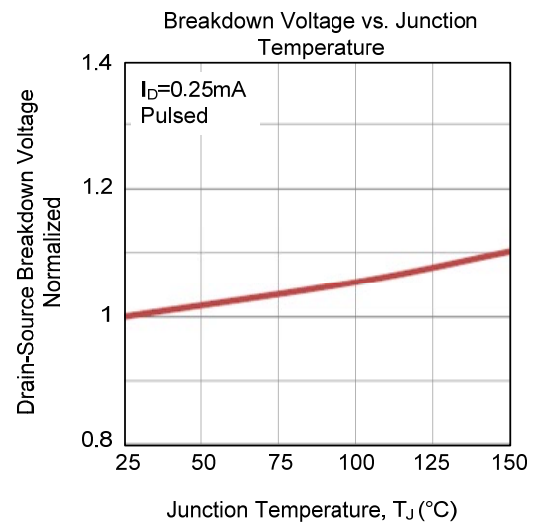
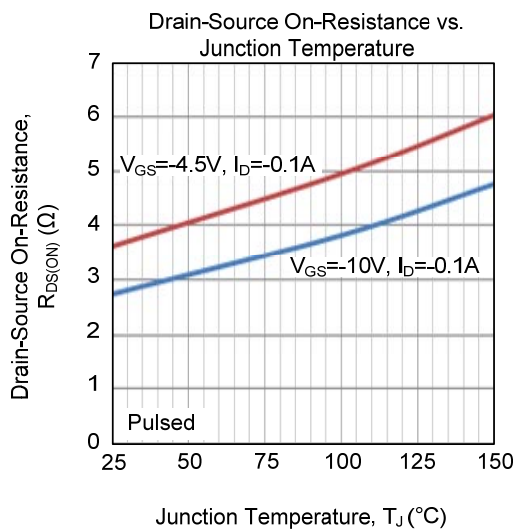
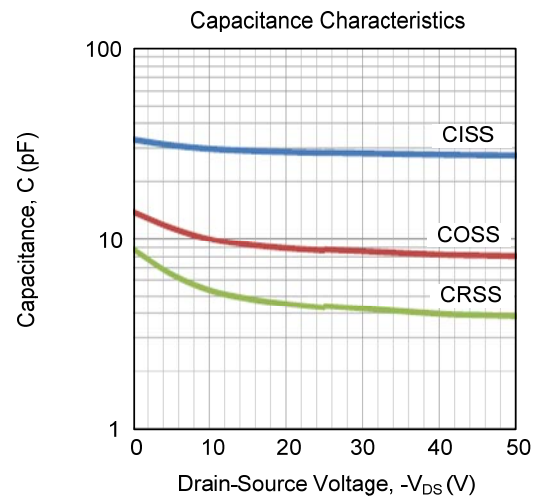
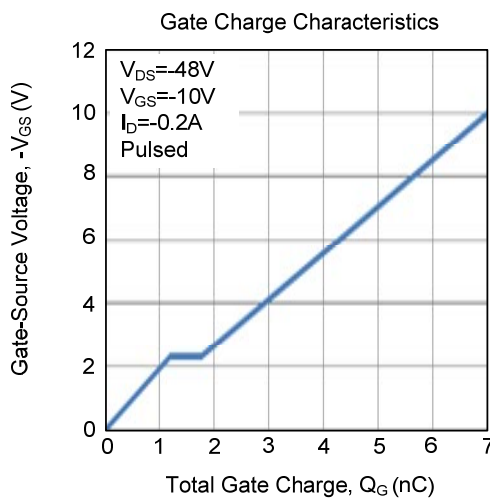
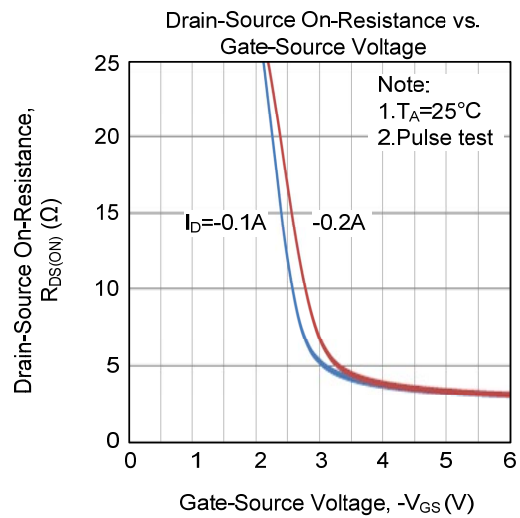
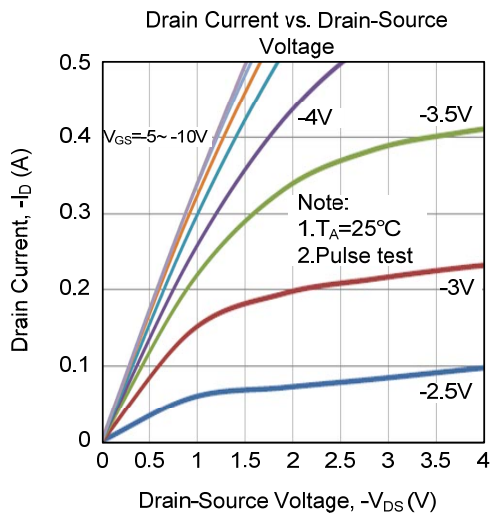


Unclamped Inductive Switching Test Circuit

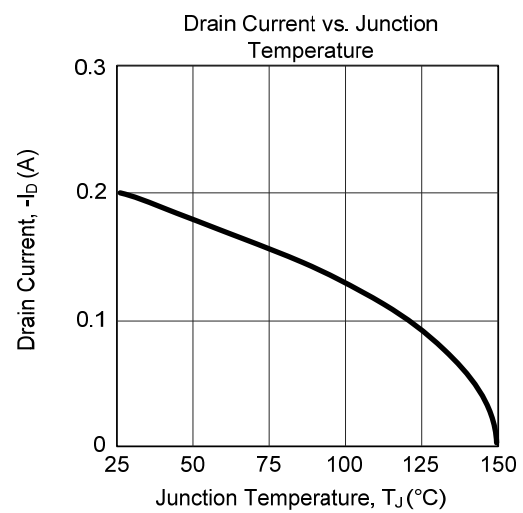
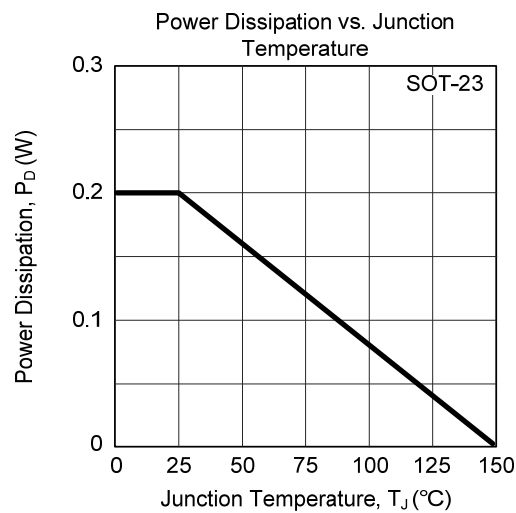
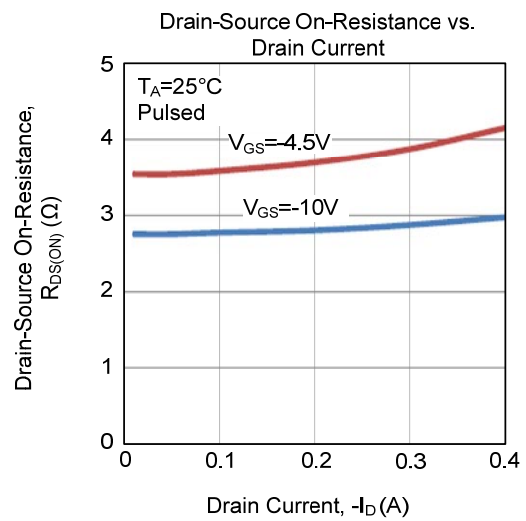
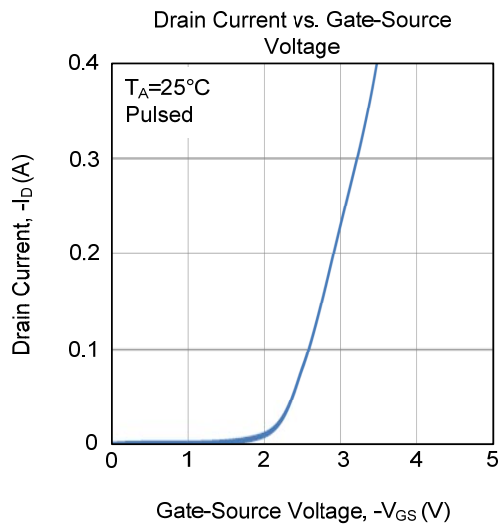
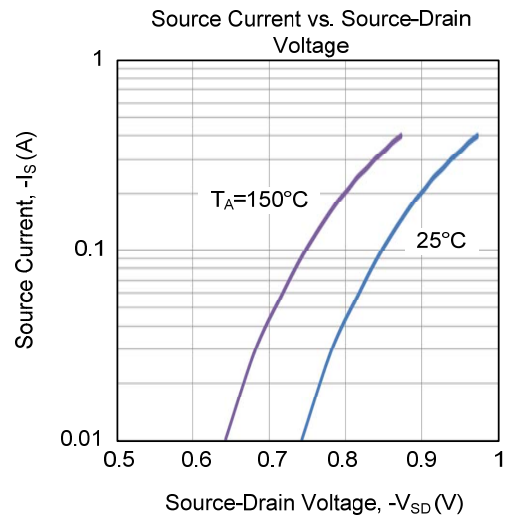
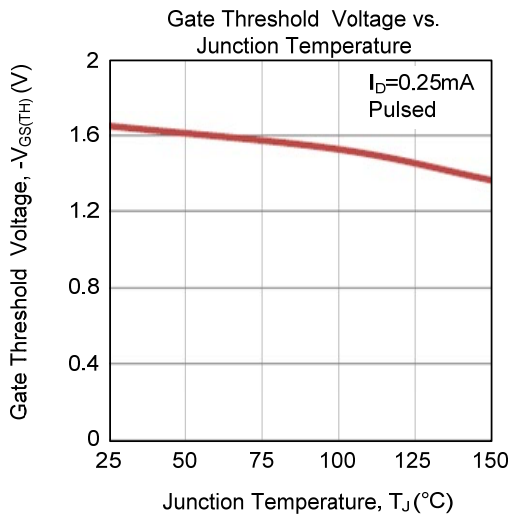


Unclamped Inductive Switching Waveforms

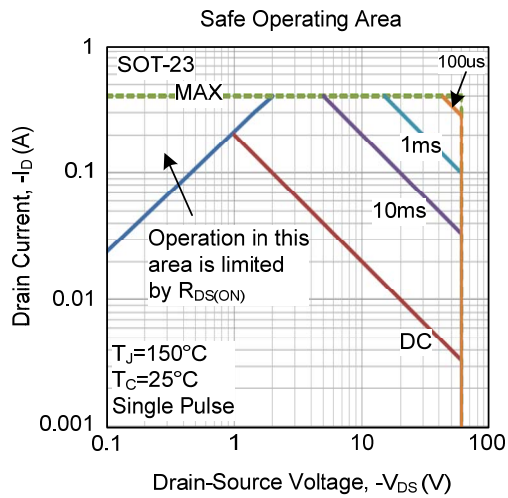
TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.